

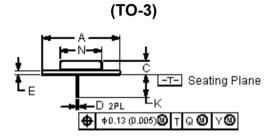


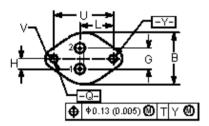
High power NPN silicon power transistors.

These devices are designed for linear amplifiers, series pass regulators, and inductive switching applications.

Features:

- Forward biased second breakdown current capability $I_{S/b} = 2.5 \text{ A dc}$ at $V_{CE} = 60 \text{V dc}$.
- Pb-free packages.





Style 1: Pin 1. Base 2. Emitter Collector (Case)

| Dimensions | Minimum Maximun | | |
|------------|-------------------------|---------------|--|
| А | 1.550 (39.37) Reference | | |
| В | - | 1.050 (26.67) | |
| С | 0.250 (6.35) | 0.335 (8.51) | |
| D | 0.038 (0.97) | 0.043 (1.09) | |
| E | 0.055 (1.40) | 0.070 (1.77) | |
| G | 0.430 (10.92) BSC | | |
| Н | 0.215 (5.46) BSC | | |
| K | 0.440 (11.18) | 0.480 (12.19) | |
| L | 0.665 (16.89) BSC | | |
| N | - | 0.830 (21.08) | |
| Q | 0.151 (3.84) | 0.165 (4.19) | |
| U | 1.187 (30.15) BSC | | |
| V | 0.131 (3.33) | 0.188 (4.77) | |

Dimensions : Inches (Millimetres)

20 and 30 Ampere Power Transistors NPN Silicon 40 and 60 Volts, 150 Watts



(TO-3) Case 1-07 Style 1



Maximum Ratings (Note 1)

| Rating | Symbol | 2N3772 | Unit | |
|--|--------------------|--------------|----------------|--|
| Collector-Emitter Voltage | V _{CEO} | 60 | | |
| Collector-Emitter Voltage | V _{CEX} | 80 | V / -l- | |
| Collector-Base Voltage | V _{CB} | 100 | V dc | |
| Emitter-Base Voltage | V _{EB} | 7.0 | | |
| Collector Current - Continuous - Peak | I _C | 20 30 | A do | |
| Base Current - Continuous - Peak | I _B | 5.0 15 | - A dc | |
| Total Device Dissipation at T _C = 25°C Derate above 25°C | P _D | 150 0.855 | W W/°C | |
| Operating and Storage Junction Temperature Range | $T_{J_{i}}T_{stg}$ | -65 to +200 | °C | |

Thermal Characteristics

| Characteristics | Symbol | Maximum | Unit |
|--------------------------------------|----------------------|---------|------|
| Thermal Resistance, Junction-to-Case | θ^{JC} | 1.17 | °C/W |

Stresses exceeding maximum ratings may damage the device. Maximum ratings are stress ratings only. Functional operation above the recommended operating conditions is not implied. Extended exposure to stresses above the recommended operating conditions may affect device reliability.

Electrical Characteristics (T_C = 25°C unless otherwise noted)

| Characteristic | | Symbol | Minimum | Maximum | Unit |
|--|------------------|------------------------|---------|-----------|---------|
| Off Characteristics | | | | | |
| Collector-Emitter Sustaining Voltage (Note 2 and 3) ($I_C = 0.2 \text{ A dc}, I_B = 0$) | 2N3772 | V _{EO (sus)} | 60 | - | |
| Collector-Emitter Sustaining Voltage ($I_C = 0.2A \text{ dc}, V_{EB \text{ (off)}} = 1.5 \text{ V dc}, R_{BE} = 100\Omega$) | 2N3772 | V _{CEX (sus)} | 80 | - | V dc |
| Collector-Emitter Sustaining Voltage ($I_C = 0.2A \text{ dc}, R_{BE} = 100\Omega$) | 2N3772 | V _{CER (sus)} | 70 | - | |
| Collector Cut off Current (Note 2) $(V_{CE} = 50V \text{ dc}, I_B = 0)$ $(V_{CE} = 25V \text{ dc}, I_B = 0)$ | 2N3772 | I _{CEO} | - | 10 | - mA dc |
| Collector Cut off Current (Note 2) (V_{CE} = 100V dc, $V_{EB (off)}$ = 1.5V dc) (V_{CE} = 45V dc, $V_{EB (off)}$ = 1.5V dc, V_{CE} = 150°C | 2N3772 2N3772 | I _{CEV} | - | 5.0 10 | |



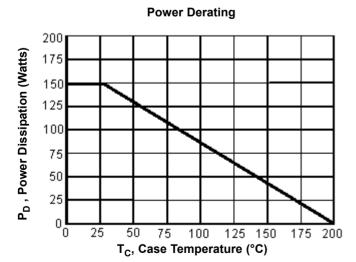
^{1.} Indicates JEDEC registered data.



Electrical Characteristics (T_C = 25°C unless otherwise noted)

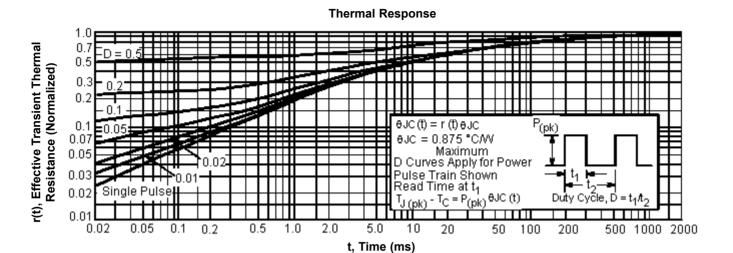
| Characteristic | | Symbol | Minimum | Maximum | Unit |
|--|---------------------------------|-----------------------|-----------|------------|---------|
| Collector Cut off Current (Note 2) (V _{CB} = 100V dc, I _E = 0) | 2N3772 | I _{CBO} | - | 5.0 | mA dc |
| Emitter Cut off Current (Note 2) (V _{BE} = 7.0Vdc, I _C = 0) | 2N3772 | I _{EBO} | - | 5.0 | IIIA UC |
| On Characteristics (Note 2) | | | | | |
| DC Current Gain (Note 3) $(I_C = 10A \text{ dc}, V_{CE} = 4.0V \text{ dc})$ $(I_C = 20A \text{ dc}, V_{CE} = 4.0V \text{ dc})$ | 2N3772 2N3772 | h _{FE} | 15 5.0 | 60 - | - |
| Collector-Emitter Saturation Voltage ($I_C = 10A \text{ dc}$, $I_B = 1.0A \text{ dc}$) ($I_C = 20A \text{ dc}$, $I_B = 4.0A \text{ dc}$) | 2N3772 2N3772 | V _{CE (sat)} | - | 1.4 4.0 | V dc |
| Base-Emitter on Voltage $(I_C = 10A \text{ dc}, V_{CE} = 4.0V \text{ dc})$ $(I_C = 8.0A \text{ dc}, V_{CE} = 4.0V \text{ dc})$ | 2N3772 | V _{BE (on)} | - | 2.2 | |
| Dynamic Characteristics (Note 2) | | | | | |
| Current-Gain - Bandwidth Product ($I_C = 1.0A$ dc, $V_{CE} = 4.0V$ dc, $f_{test} = 50kHz$) | | f _T | 0.2 | - | MHz |
| Small-Signal Current Gain ($I_C = 1.0 A$ dc, $V_{CE} = 4.0 V$ dc, $f = 1.0 A$ dc) | | h _{fe} | 40 | - | - |
| Second Breakdown | | | , | | |
| Second Breakdown Energy with Base Forward Biased, $t = (V_{CE} = 60V \text{ dc})$ | 1.0s (non-repetitive) 2N3772 | I _{S/b} | 2.5 | - | A dc |

- 2. Indicates JEDEC registered data.
- 3. Pulse Test: 300µs, Rep. Rate 60cps.

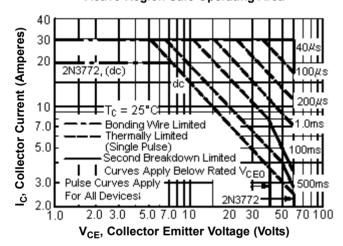






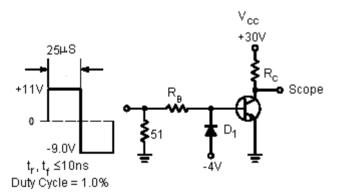


Active-Region Safe Operating Area



There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation: i.e., the transistor must not be subjected to greater dissipation than curves indicate.

Is based on JEDEC registered data. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J\,(pk)} < 200^{\circ} C.$ $T_{J\,(pk)}$ may be calculated from the data of using data of and the pulse power limits of Figure 3, $T_{J\,(pk)}$ will be found to be less than $T_{J\,(max)}$ for pulse widths of 1ms and less. When using ON Semiconductor transistors, it is permissible to increase the pulse power limits until limited by $T_{J\,(maximum)}$.



 $\rm R_B$ and $\rm R_C$ are varied to obtain desired current levels D1 must be fast recovery type, e.g.: 1N5825 used above $\rm I_B$ to 100mA MSD6100 used below $\rm I_B$ to 100mA

Switching Time Test Circuit

Turn-On Time

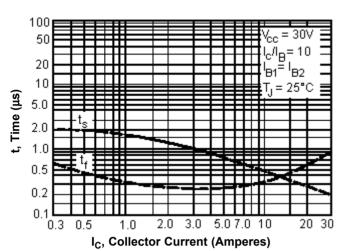
10
5.0
V_{CC} = 30
V_{CC} = 30
V_{BE} (off) = 5.0V

1.0
0.5
0.2
0.1
0.05
0.02
0.01
0.3 0.5 0.7 1.0 2.0 3.0 5.0 7.0 10 20 30
I_C, Collector Current (Amperes)



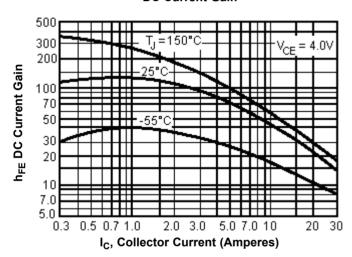




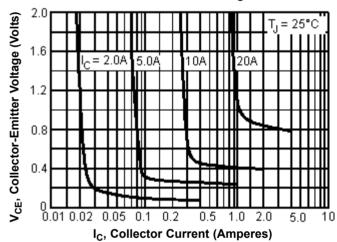


Capacitance 2000 $T_1 = 25^{\circ}C$ C, Capacitance (pF) 1000 700 500 300 200 0.1 0.2 20 50 100 0.5 1.0 2.0 5.0 10 V_R, Reverse Voltage (Volts)

DC Current Gain



Collector Saturation Region



Part Number Table

| Description | Part Number | | |
|-----------------------|-------------|--|--|
| Transistor, NPN, TO-3 | 2N3772 | | |

Disclaimer This data sheet and its contents (the "Information") belong to the Premier Farnell Group (the "Group") or are licensed to it. No licence is granted for the use of it other than for information purposes in connection with the products to which it relates. No licence of any intellectual property rights is granted. The Information is subject to change without notice and replaces all data sheets previously supplied. The Information supplied is believed to be accurate but the Group assumes no responsibility for its accuracy or completeness, any error in or omission from it or for any use made of it. Users of this data sheet should check for themselves the Information and the suitability of the products for their purpose and not make any assumptions based on information included or omitted. Liability for loss or damage resulting from any reliance on the Information or use of it (including liability resulting from negligence or where the Group was aware of the possibility of such loss or damage arising) is excluded. This will not operate to limit or restrict the Group's liability for death or personal injury resulting from its negligence. SPC Multicomp is the registered trademark of the Group. © Premier Farnell plc 2008.

